

# CSD19535KTT 100V N 通道 NexFET™ 功率 MOSFET

## 1 特性

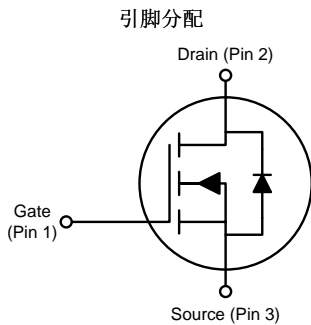
- 超低  $Q_g$  和  $Q_{gd}$
- 低热阻
- 雪崩额定值
- 无铅引脚镀层
- 符合 RoHS 环保标准
- 无卤素
- D<sup>2</sup>PAK 塑料封装

## 2 应用

- 热插拔
- 电机控制
- 二次侧同步整流器

## 3 说明

这款 100V、2.8mΩ D<sup>2</sup>PAK (TO-263) NexFET™ 功率 MOSFET 被设计成在功率转换应用中大大降低 损耗。



### 产品概要

$T_A = 25^\circ\text{C}$		典型值		单位
$V_{DS}$	漏源电压	100		V
$Q_g$	栅极电荷总量 (10V)	75		nC
$Q_{gd}$	栅极电荷 (栅极到漏极)	11		nC
$R_{DS(on)}$	漏源导通电阻	$V_{GS} = 6\text{V}$	3.2	mΩ
		$V_{GS} = 10\text{V}$	2.8	
$V_{GS(th)}$	阈值电压	2.7		V

### 器件信息(1)

器件	数量	包装介质	封装	运输
CSD19535KTT	500	13 英寸卷带	D <sup>2</sup> PAK 塑料封装	卷带封装
CSD19535KTTT	50			

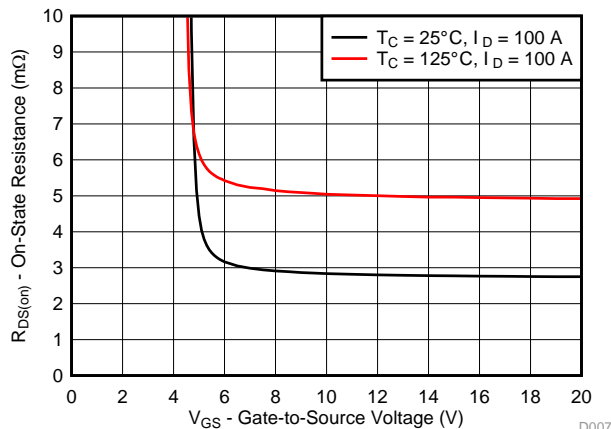
(1) 要了解所有可用封装，请参阅数据表末尾的可订购产品附录。

### 绝对最大额定值

$T_A = 25^\circ\text{C}$		值	单位
$V_{DS}$	漏源电压	100	V
$V_{GS}$	栅源电压	$\pm 20$	V
$I_D$	持续漏极电流 (受封装限制)	200	A
	持续漏极电流 (受芯片限制), $T_C = 25^\circ\text{C}$ 时测得	197	
	持续漏极电流 (受芯片限制), $T_C = 100^\circ\text{C}$ 时测得	139	
$I_{DM}$	脉冲漏极电流 <sup>(1)</sup>	400	A
$P_D$	功耗, $T_C = 25^\circ\text{C}$	300	W
$T_J, T_{stg}$	工作结温, 储存温度	-55 至 175	$^\circ\text{C}$
$E_{AS}$	雪崩能量, 单一脉冲 $I_D = 95\text{A}, L = 0.1\text{mH}$	451	mJ

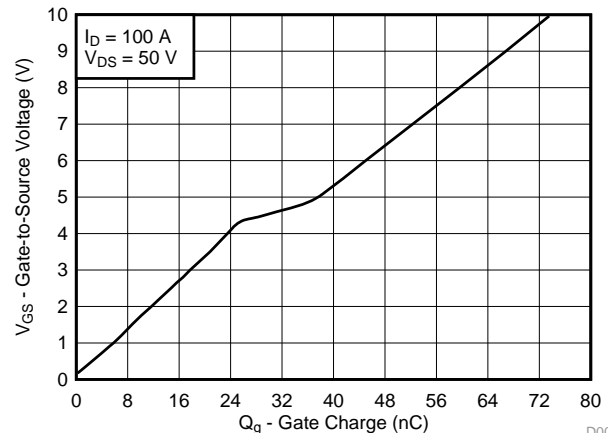
(1) 最大  $R_{\theta JC} = 0.5^\circ\text{C}/\text{W}$ , 脉冲持续时间  $\leq 100\mu\text{s}$ , 占空比  $\leq 1\%$ 。

$R_{DS(on)}$  与  $V_{GS}$  对比



D007

栅极电荷



D004



## 目录

1	特性 .....	1	6.1	接收文档更新通知 .....	7
2	应用 .....	1	6.2	社区资源 .....	7
3	说明 .....	1	6.3	商标 .....	7
4	修订历史记录 .....	2	6.4	静电放电警告 .....	7
5	<b>Specifications</b> .....	3	6.5	Glossary .....	7
	5.1 Electrical Characteristics .....	3	7	<b>机械、封装和可订购信息</b> .....	8
	5.2 Thermal Information .....	3	7.1	KTT 封装尺寸 .....	8
	5.3 Typical MOSFET Characteristics .....	4	7.2	建议 PCB 布局 .....	9
6	器件和文档支持 .....	7	7.3	建议模版开孔 (0.125mm 模版厚度) .....	9

## 4 修订历史记录

### Changes from Revision A (May 2015) to Revision B

**Page**

•	已添加 向器件和文档支持 部分添加了接收文档更新通知 部分 .....	7
•	已更改 <i>KTT</i> 封装尺寸 部分中的图 .....	8
•	已更改 建议 <i>PCB</i> 布局 部分中的图 .....	9
•	已更改 建议模版开孔 (0.125mm 模版厚度) 部分中的图 .....	9

### Changes from Original (March 2015) to Revision A

**Page**

•	已添加 <a href="#">社区资源</a> .....	7
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## 5 Specifications

### 5.1 Electrical Characteristics

 $T_A = 25^\circ\text{C}$  (unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>STATIC CHARACTERISTICS</b>						
$BV_{DSS}$	Drain-to-source voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	100			V
$I_{DSS}$	Drain-to-source leakage current	$V_{GS} = 0\text{ V}, V_{DS} = 80\text{ V}$			1	$\mu\text{A}$
$I_{GSS}$	Gate-to-source leakage current	$V_{DS} = 0\text{ V}, V_{GS} = 20\text{ V}$			100	nA
$V_{GS(th)}$	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2.2	2.7	3.4	V
$R_{DS(on)}$	Drain-to-source on resistance	$V_{GS} = 6\text{ V}, I_D = 100\text{ A}$		3.2	4.1	m $\Omega$
		$V_{GS} = 10\text{ V}, I_D = 100\text{ A}$		2.8	3.4	
$g_{fs}$	Transconductance	$V_{DS} = 10\text{ V}, I_D = 100\text{ A}$		301		S
<b>DYNAMIC CHARACTERISTICS</b>						
$C_{iss}$	Input capacitance	$V_{GS} = 0\text{ V}, V_{DS} = 50\text{ V}, f = 1\text{ MHz}$		6100	7930	pF
$C_{oss}$	Output capacitance			1160	1510	pF
$C_{rss}$	Reverse transfer capacitance			29	38	pF
$R_G$	Series gate resistance			1.4	2.8	$\Omega$
$Q_g$	Gate charge total (10 V)	$V_{DS} = 50\text{ V}, I_D = 100\text{ A}$		75	98	nC
$Q_{gd}$	Gate charge gate-to-drain			11		nC
$Q_{gs}$	Gate charge gate-to-source			25		nC
$Q_{g(th)}$	Gate charge at $V_{th}$			16		nC
$Q_{oss}$	Output charge	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		210		nC
$t_{d(on)}$	Turnon delay time	$V_{DS} = 50\text{ V}, V_{GS} = 10\text{ V}, I_{DS} = 100\text{ A}, R_G = 0\ \Omega$		9		ns
$t_r$	Rise time			18		ns
$t_{d(off)}$	Turnoff delay time			21		ns
$t_f$	Fall time			15		ns
<b>DIODE CHARACTERISTICS</b>						
$V_{SD}$	Diode forward voltage	$I_{SD} = 100\text{ A}, V_{GS} = 0\text{ V}$		0.9	1.1	V
$Q_{rr}$	Reverse recovery charge	$V_{DS} = 50\text{ V}, I_F = 100\text{ A}, di/dt = 300\text{ A}/\mu\text{s}$		435		nC
$t_{rr}$	Reverse recovery time			85		ns

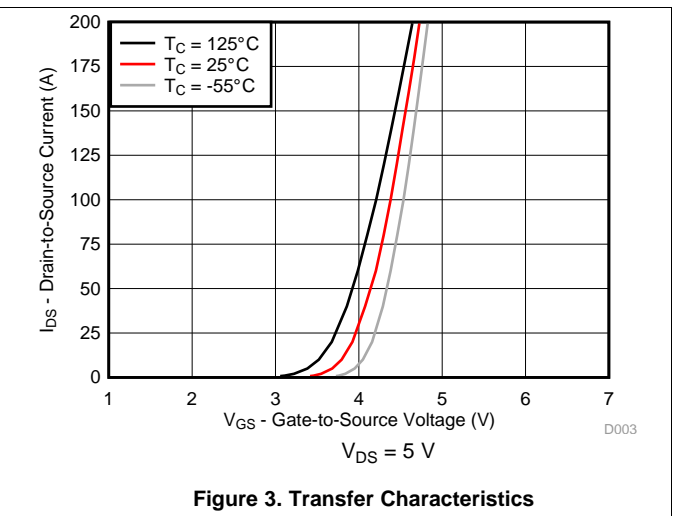
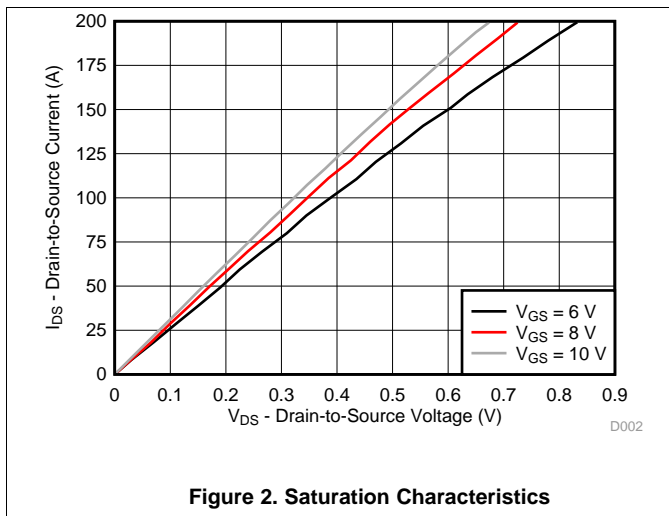
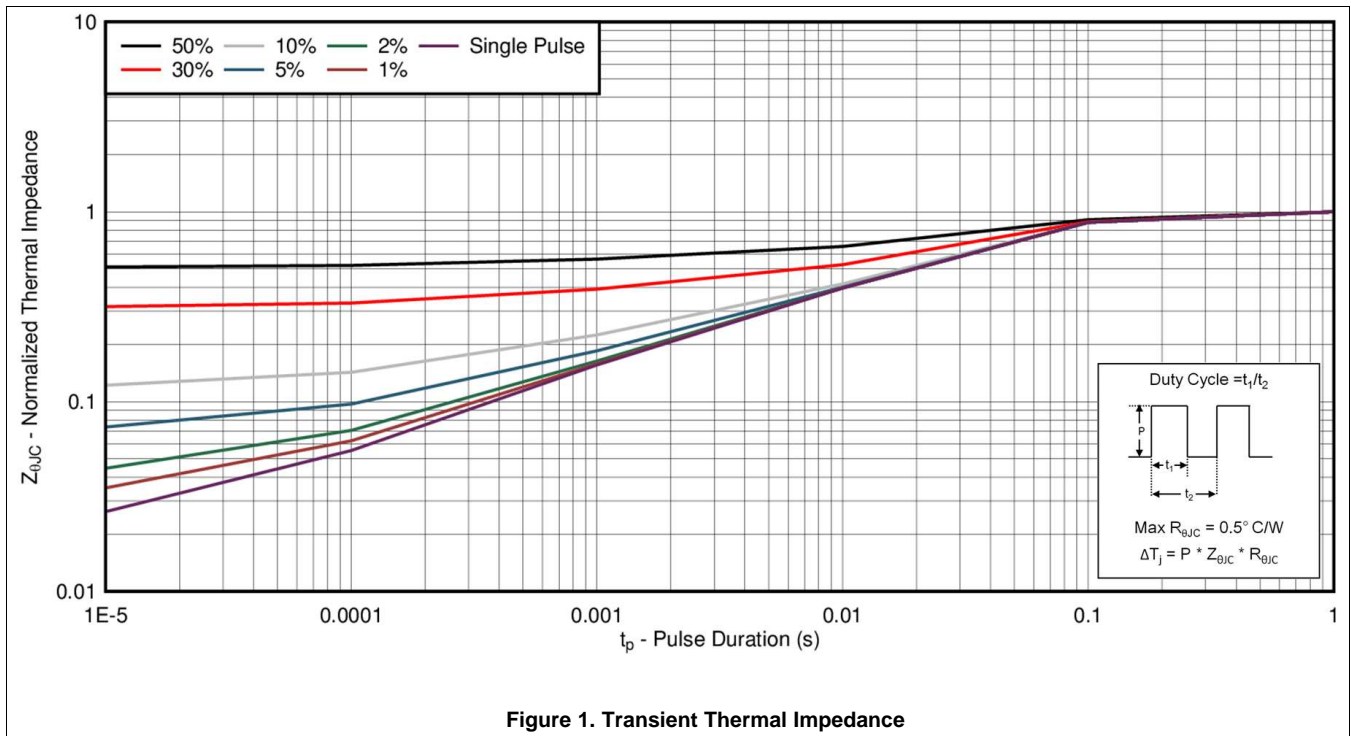
### 5.2 Thermal Information

 $T_A = 25^\circ\text{C}$  (unless otherwise stated)

THERMAL METRIC		MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			0.5	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-ambient thermal resistance			62	$^\circ\text{C}/\text{W}$

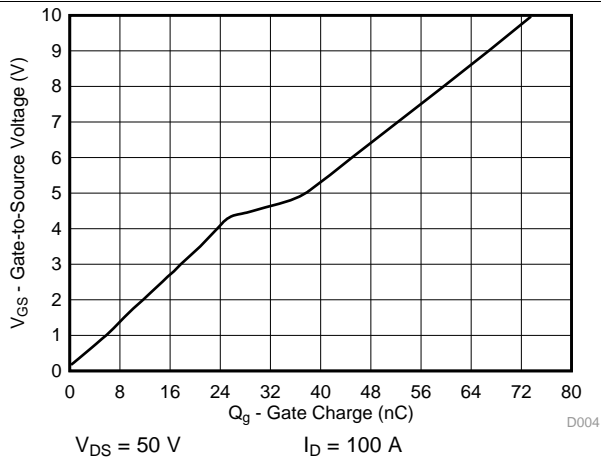
### 5.3 Typical MOSFET Characteristics

T<sub>A</sub> = 25°C (unless otherwise stated)

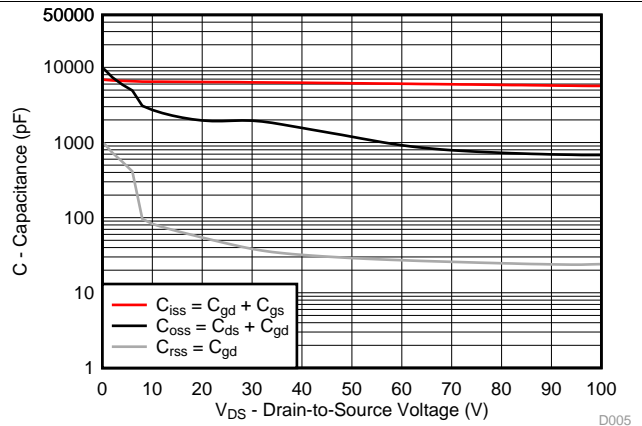


**Typical MOSFET Characteristics (continued)**

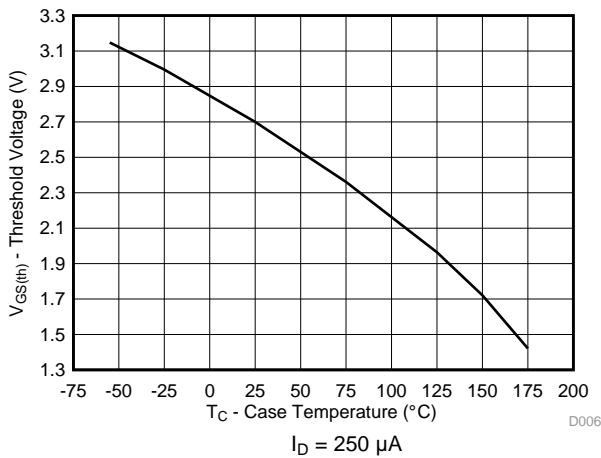
T<sub>A</sub> = 25°C (unless otherwise stated)



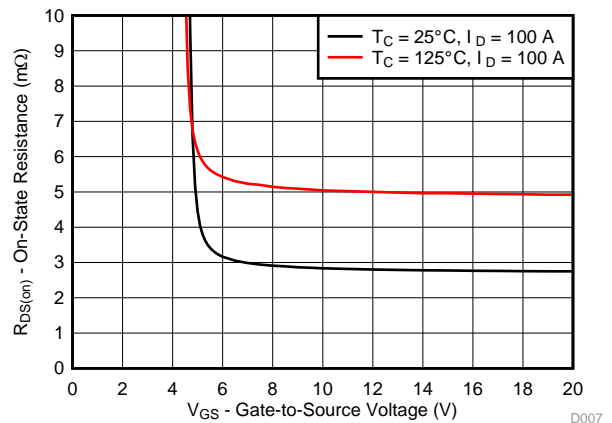
**Figure 4. Gate Charge**



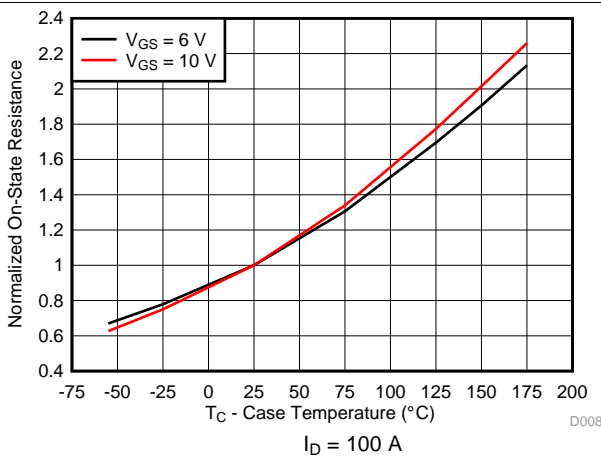
**Figure 5. Capacitance**



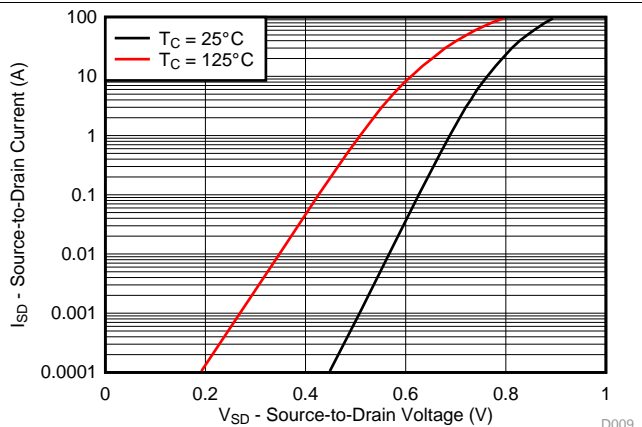
**Figure 6. Threshold Voltage vs Temperature**



**Figure 7. On-State Resistance vs Gate-to-Source Voltage**



**Figure 8. Normalized On-State Resistance vs Temperature**



**Figure 9. Typical Diode Forward Voltage**

Typical MOSFET Characteristics (continued)

T<sub>A</sub> = 25°C (unless otherwise stated)

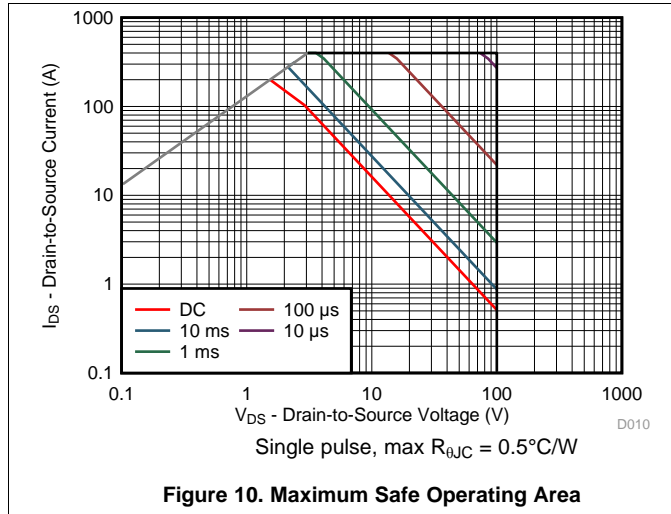


Figure 10. Maximum Safe Operating Area

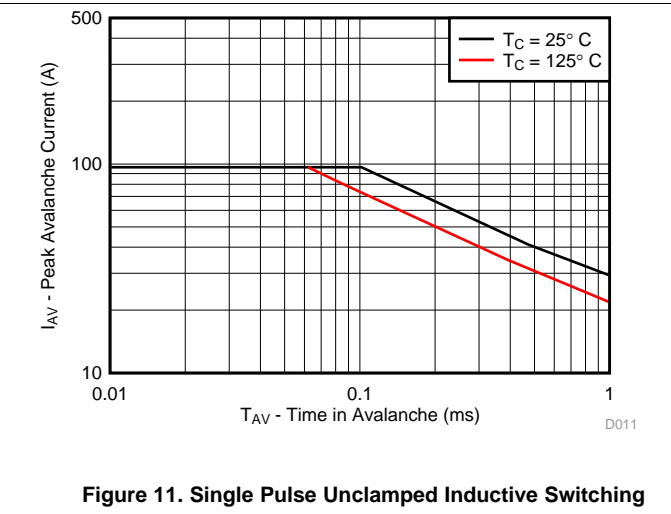


Figure 11. Single Pulse Unclamped Inductive Switching

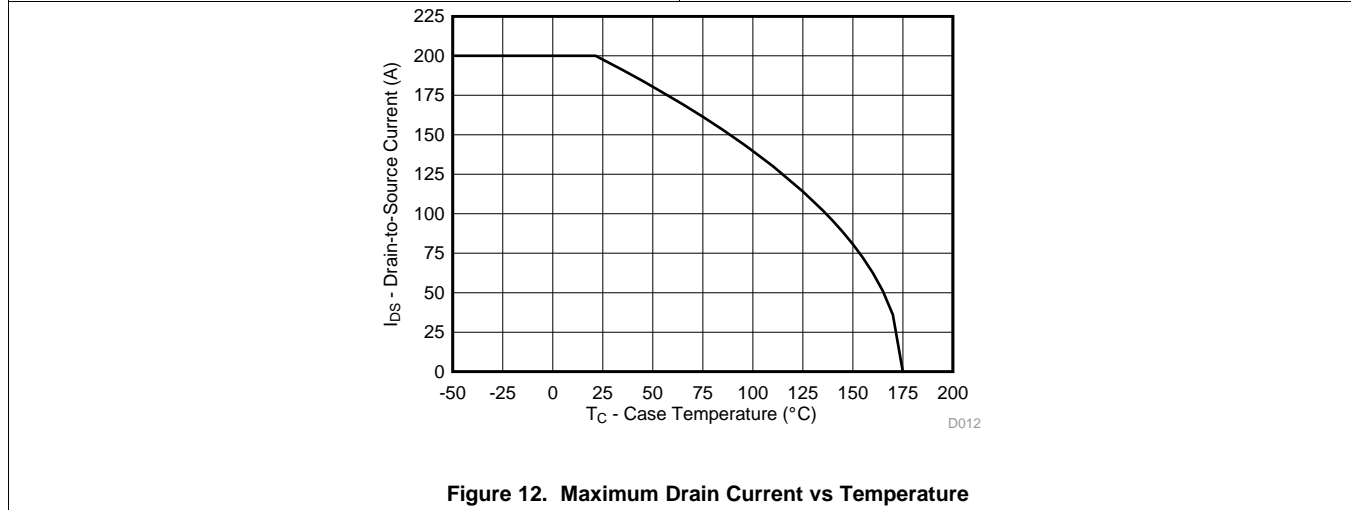


Figure 12. Maximum Drain Current vs Temperature

## 6 器件和文档支持

### 6.1 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](http://ti.com) 上的器件产品文件夹。请单击右上角的 [通知我](#) 进行注册，即可收到任意产品信息更改每周摘要。有关更改的详细信息，请查看任意已修订文档中包含的修订历史记录。

### 6.2 社区资源

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**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 6.3 商标

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### 6.4 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

### 6.5 Glossary

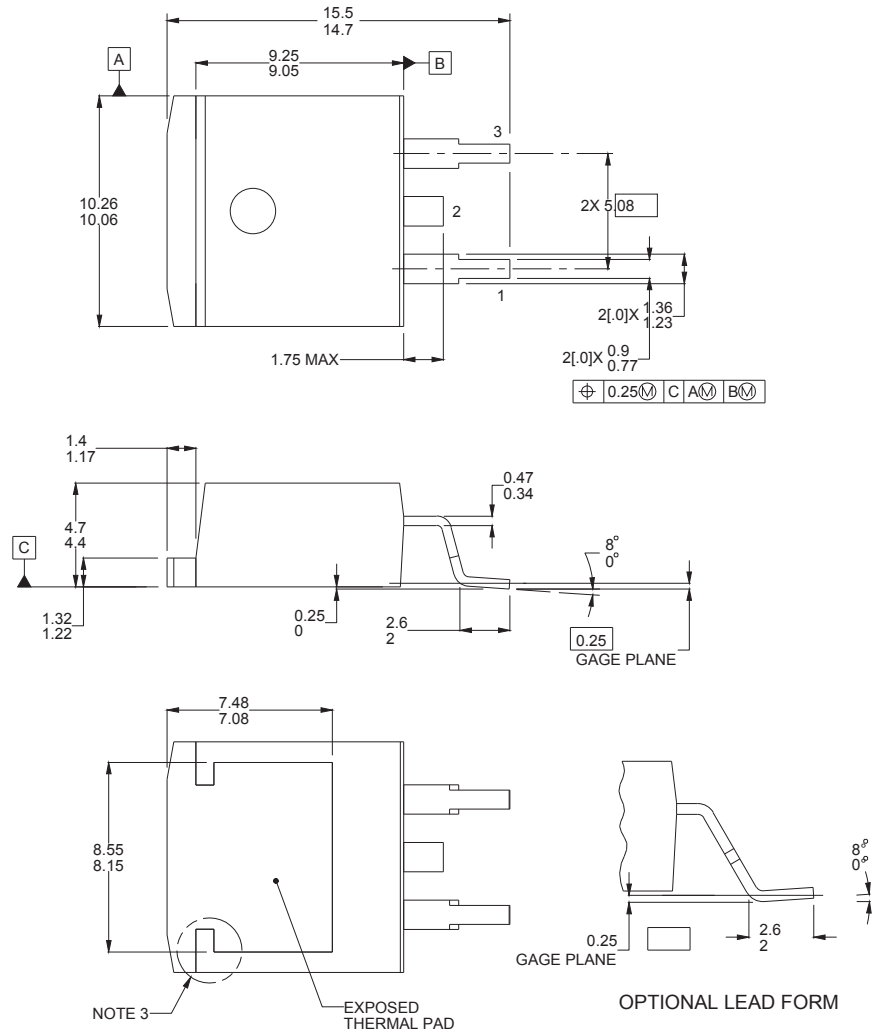
**SLYZ022** — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 7 机械、封装和可订购信息

以下页面包括机械、封装和可订购信息。这些信息是指定器件的最新可用数据。这些数据发生变化时，我们可能不会另行通知或修订此文档。如欲获取此产品说明书的浏览器版本，请参见左侧的导航栏。

### 7.1 KTT 封装尺寸



注:



1. 所有线性尺寸的单位均为毫米。括号中的任何尺寸仅供参考。尺寸和容限值遵循 ASME Y14.5M。
2. 本图纸如有变更，恕不通知。
3. 来自不同装配现场的产品可能不具备某些特性，形状也可能有所不同。

表 1. 引脚配置

位置	名称
引脚 1	栅极
引脚 2 / 标签	漏极
引脚 3	源极



**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD19535KTT	ACTIVE	DDPAK/ TO-263	KTT	3	500	RoHS-Exempt & Green	SN	Level-2-260C-1 YEAR	-55 to 175	CSD19535KTT	
CSD19535KTTT	ACTIVE	DDPAK/ TO-263	KTT	3	50	RoHS-Exempt & Green	SN	Level-2-260C-1 YEAR	-55 to 175	CSD19535KTT	

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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